ORIGINAL ARTICLE



Enhancing 3D Reconstruction Accuracy of FIB Tomography Data Using Multi-voltage Images and Multimodal Machine Learning

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Received: 6 November 2023 / Revised: 10 January 2024 / Accepted: 10 January 2024 © The Author(s) 2024

Abstract

FIB-SEM tomography is a powerful technique that integrates a focused ion beam (FIB) and a scanning electron microscope (SEM) to capture high-resolution imaging data of nanostructures. This approach involves collecting in-plane SEM images and using FIB to remove material layers for imaging subsequent planes, thereby producing image stacks. However, these image stacks in FIB-SEM tomography are subject to the *shine-through effect*, which makes structures visible from the posterior regions of the current plane. This artifact introduces an ambiguity between image intensity and structures in the current plane, making conventional segmentation methods such as thresholding or the k-means algorithm insufficient. In this study, we propose a multimodal machine learning approach that combines intensity information obtained at different electron beam accelerating voltages to improve the three-dimensional (3D) reconstruction of nanostructures. By treating the increased *shine-through effect* at higher accelerating voltages as a form of *additional* information, the proposed method significantly improves segmentation accuracy and leads to more precise 3D reconstructions for real FIB tomography data.

Highlights

- 1. FIB-SEM tomography can be used to acquire high-resolution image stacks of nanostructures.
- 2. Machine learning reduces artifacts and ambiguities introduced in FIB-SEM tomography because of the *shine-through effect*.
- 3. Our approach treats the *shine-through effect* as a valuable *additional* information for precise reconstruction.
- 4. Using multi-voltage images, our multimodal ML approach improves 3D reconstruction accuracy.

Keywords Multimodal machine learning \cdot Multi-voltage images \cdot FIB-SEM \cdot Overdeterministic systems \cdot 3D reconstruction \cdot FIB tomography

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1 Introduction

Structural analysis is essential in materials science, enabling the precise characterization and modeling of complex materials. This knowledge facilitates the implementation of these materials in the mass production industry and everyday life [1]. However, high-resolution imaging techniques are typically required to investigate materials with nanoscale features, which limit the range of suitable methods. For instance, when examining hierarchical nanoporous materials such as those in our case with ligament sizes larger than 100 nm and nanopores smaller than 20 nm, conventional techniques, such as X-ray nanotomography, may lack the necessary resolution [2].

Electron microscopy, particularly focused ion beam (FIB) tomography in conjunction with scanning electron microscopy (SEM), offers the essential resolution for analyzing conductive hierarchical nanoporous materials. FIB removes nanometer-thin layers of material after each SEM imaging step, building a stack of images for subsequent three-dimensional (3D) reconstruction. Although FIB-SEM tomography has been applied to the study of nanoporous gold and hierarchical nanoporous gold (HNPG) in various studies [3–5], several challenges persist.

First, the variation in slice thickness in FIB tomography images can introduce inaccuracies in 3D reconstructions. A slice repositioning method was proposed to address this issue, and a machine learning (ML) method was adopted to solve this problem from the perspective of an image inpainting problem [6].

The *shine-through effect* is another challenge, where structures from posterior regions become visible through pores in the currently milled plane [7]. This effect complicates the mapping between actual structure and image intensity [8, 9]. While classical machine learning methods like random forests or k-means clustering are effective in cases where the *shine-through effect* is minimal [8, 10], the utility of more advanced machine learning techniques for suppressing this effect in cases where it is non-negligible was demonstrated [11, 12]. They used simulated data to train machine learning models and successfully applied these optimized models to real nanostructures. This technique, known as transfer learning, has exhibited notable performance in materials science applications [13].

The extent of the *shine-through effect* is directly related to the beam energy (Fig. 1), allowing its use as an auxiliary method to establish an overdetermined system and collect a comprehensive SEM dataset. In other words, by analyzing images acquired at different voltages, it is possible to separate the *shine-through effect* signal from the surface area signal, ultimately enabling the reconstruction of hierarchical nanoporous structures with significantly improved accuracy.



Fig. 1 Schematic overview of multi-voltage image acquisition: penetration of electron beam (e-beam) into microstructure from the top (top row) for acceleration voltages of 1 kV (**A**), 2 kV (**B**), and 4 kV (**C**) and resulting planar SEM image (bottom row)

We use advanced ML methods to solve the overdetermined system obtained from images obtained at different voltages.

In general, multimodal ML leverages different data types, such as speech and images, to improve task-specific performance [14]. In medical imaging, multimodal data fusion, such as combining positron emission tomography with computed tomography and/or magnetic resonance imaging, enhances lesion quantification [15–18]. Shared image features from unregistered views enhance classification [19]. A comprehensive summary of multimodal ML developments in medical imaging can be found in [20]. In electron microscopy, combining signals from high-angle annular dark-field and energy-dispersive X-ray spectroscopy facilitates the 3D reconstruction of nanostructures [21], and combining transmission X-ray microscopy with FIB-SEM improves the image quality for shale analysis [22].

In this study, we present a novel ML-based method for a multi-voltage (multiV) FIB tomography dataset of HNPG. To develop this method, we created synthetic multiV images using a Monte Carlo-based method [12]. These simulated multiV data are used to train ML models. We compared different segmentation methods and demonstrated significant segmentation improvements with multiple modalities. In particular, our multimodal ML method outperforms single-modality ML methods in mitigating the *shine-through effect*.

2 Materials and Methods

2.1 Acquisition of Imaging Data

In this study, we used imaging data obtained from both real HNPG samples and computer-generated synthetic imaging data, closely resembling actual HNPG imaging data, to construct datasets for ML.

2.1.1 Real Samples

An HNPG sample featuring a uniform random network structure with two well-defined ligament sizes of 15 and 110 nm was prepared using the dealloying-coarsening-dealloying method [23]. To improve SEM imaging and distinguish solid and pore phases, epoxy resin infiltration was employed because it provides a dark, homogeneous background during SEM imaging [24]. MultiV FIB tomography of the HNPG sample was performed using a Dual Beam FEI Helios NanoLab G3 system, integrating ASV4 Thermo Fisher Scientific Inc (2017) software [25] for automated tomography control. This software acquires electron- and ion-beam images to monitor milling progress and compensate for image drift resulting from various sources, including charge effects, mechanical stage drift, and thermal-induced drift [26].

To perform drift compensation during FIB tomography, two fiducial markers were prepared and positioned on the side of the region of interest (ROI). Each fiducial marker comprised two perpendicularly intersecting trenches milled on a platinum-deposited area, separate from the ROI. In addition, a ruler system was implemented on top of the ROI to ensure precise slice thickness determination, following a methodology similar to that presented in [27] and optimized for HNPG tomography [3]. This approach involved sputtering a 1-µm carbon layer atop the ROI to smoothen the surface and render the ruler visible (see Fig. 2).

During multiV tomography, each slice was imaged three times with accelerating voltages of 1, 2, and 4 kV at a constant current of 50 pA. This process generated three real FIB tomography image datasets referred to as r-1 kV, r-2 kV, and r-4 kV (where the letter "r" refers to the fact that the data are based on real rather than synthetic, computer-generated microstructures). The SEM image parameters included a resolution of 3072×2048 and a horizontal field of view spanning 10 µm, resulting in a pixel size of 3.26 nm. Lownoise imaging was achieved with a dwell time of 30 µs. A through-the-lens detector (TLD) was used to detect back-scattered electrons (BSEs).

In total, 316 slices were milled using an ion beam with an aperture of 80 pA and an accelerating voltage of 30 kV. This dataset yielded a mean slice thickness of $\langle d \rangle = 10.16$ nm,



Fig. 2 Experimental dataset. **A** Schematic overview. Dark areas with white crosses represent fiducial structures for drift compensation. **B** Imaged block face-electron-beam view (BSE, TLD, 2 kV, 50 pA, 52° tilt) and **C** milling view (ETD, SE, 30 kV, 80 pA, 0° tilt) with

(1) ruler structure, (2) e-beam fiducial structure, (3) HNPG infiltrated with epoxy, (4) ion-beam fiducial structure, (5) 30-µm deep trenches, and (6) direction of ion mill (scale bar: 1 µm)



Fig. 3 Single raw FIB-SEM slice images of real HNPG at **A** 1 kV, **B** 2 kV, and **C** 4 kV, each featuring a fiducial marker in the *xy*-plane. Misalignment is evident from the marked rectangles (red), showcas-

ing variations in x- and y-directions between images acquired at different accelerating voltages. Scale bar: 1000 nm

with a standard deviation of $\sigma = 3.12$ nm, aligning closely with the target thickness of 10 nm. Notably, 9% of the slices, characterized by thickness outliers (z-scores of 1.5), were excluded from the thickness calculation analysis.

Owing to instrument constraints, misalignments frequently occur in images captured at different accelerating voltages within and across stacks (see Fig. 3). Consequently, image registration is essential to ensure that the same region is consistently exposed across all voxel groups for images obtained at different accelerating voltages. This registration process comprises two key steps:

Intra-stack image registration

The first step involves aligning the images within each image stack acquired at a specific accelerating voltage (1, 2, and 4 kV). The initial image in each stack serves as a reference. Subsequent images are translated in the (in-plane) x- and y-directions to maximize the correlation between consecutive slices. We used the Fiji plugin [28] 'Register virtual stack slices' to perform intra-stack registration.

Inter-stack image registration

After intra-stack registration, images across stacks acquired with different voltages (1, 2, and 4 kV) were aligned considering the image stack acquired at 2-kV accelerating voltage as the reference. Calculating correlations between corresponding slices in 1- and 2-kV stacks enabled translational shifts for optimal alignment. A supplementary fiducial marker, milled on the right side of the sample (Fig. 2), enhanced the inter-stack correlation as no *shine-through effect* is noticed for the region across different image stacks. Aligning the 4- and 2-kV stacks followed the same procedure. Figure 4 shows an identical slice from each dataset after the registration procedure.

2.1.2 Synthetic Samples

Supervised ML on electron microscopy data, particularly for FIB tomography of HNPG, can be challenging because of the high cost and time involved in acquiring substantial training datasets. Because ground truth images are unavailable for the FIB tomography data of HNPG, we generated synthetic FIB tomography images, as described in [12]. In the first step, virtual initial structures resembling real HNPG structures were generated using the method described in [23]. The leveled-wave model [29] provides a basis for each virtual HNPG hierarchy level. This model starts with a concentration field formed by the superimposition of waves with



Fig. 4 Aligned single identical slice of real FIB-SEM image of HNPG imaged at accelerating voltages of A 1 kV, B 2 kV, and C 4 kV; D mean intensity plot of the highlighted area (green square) for 1-, 2-, and 4-kV images. Scale bar: 300 nm



Fig. 5 Same slice of simulated FIB tomography data with accelerating voltages of A 1 kV, B 2 kV, and C 4 kV; D mean intensity plot of the highlighted area (green square) for 1-, 2-, and 4-kV images. Scale bar: 300 nm

the same wavelength but with random wave vector directions. The wave vectors have the same magnitude, which dominates the ligament size of the virtual nanoporous network. Subsequently, a level cut was selected for binarization into a pore or solid phase, and virtual nanoporous microstructures were generated after removing the pore phase. Various level cuts can be applied to achieve the desired solid fraction. In the next step, the process of FIB-SEM tomography was simulated on these binary structures by Monte Carlo simulations using the MCXray plugin of Dragonfly software [30]. We generated three datasets using the same virtual initial structure but at different accelerating voltages (1, 2, and 4 kV), similar to the real HNPG data. As shown in Fig. 5, these datasets, named s-1 kV, s-2 kV, and s-4 kV (where "s" refers to "synthetic"), resemble the real HNPG data acquired at different accelerating voltages.

2.2 Machine Learning Architectures for Semantic Segmentation

We used multimodal ML to segment the FIB tomography data semantically. Inspired by [20], we developed three architectures for 3D nanostructure reconstruction, adapted from [12], employing different data fusion techniques:

2.2.1 Early Fusion

In the early fusion architecture (Fig. 6(A)), we fused multimodal images at the input level by channel-wise concatenating single two-dimensional (2D) slices from the s-1 kV, s-2 kV, and s-4 kV datasets. These slices form the input tensor, passing through custom 2D and 3D U-Net models to produce the final segmentation output.

2.2.2 Intermediate Fusion

The intermediate fusion architecture (Fig. 6(B)) contains separate branches for each imaging modality, focusing on images at different accelerating voltages. These images pass through modality-specific subnetworks to extract low-level features, which are then concatenated and classified using a fully connected neural network to yield the final segmentation. This architecture posed challenges because of its size during the optimization process.

2.2.3 Late Fusion

The late fusion architecture (Fig. 6(C)) resembles intermediate fusion, with each branch dedicated to a different modality, initially trained and optimized. These trained ML models estimate the probabilities of each pixel belonging to either the material or pore phase. In the second step, the output probabilities from these optimized branches are collected and concatenated. These concatenated probabilities then train a final neural network layer (ensemble), which, once optimized, produces the ultimate segmentation output.

2.3 ML Model Training Process

We trained all ML architectures on Tesla K80 GPUs. Images were initially cropped into smaller patches (64×64) with a 32-pixel stride using a sliding window technique. Our networks are trained using a structured approach where data are presented as individual 2D slices, a 3D volumetric stack, or a 2D slice coupled with its neighboring slices for a 2D convolutional neural network (CNN), 2D CNN with adjacent slices, and 3D CNN. We used Dice loss in conjunction with the Adam optimizer, starting with an initial learning rate of 0.0001. If the learning rate did not decrease for ten consecutive training epochs, the learning rate was reduced by a factor of 10. Table 1 shows details of the training parameters, and supplementary (Appendix) Fig. 10 illustrates a typical training and validation data Dice loss curve.

2.4 Data Augmentation

ML requires a large set of training data. When it is difficult to collect sufficient training data, data augmentation can be a powerful method for increasing the data size for ML [31]. Differences in data distributions between synthetic and real datasets and variations stemming from different microscopes emphasize the need for extensive data augmentation in electron microscopy. We applied online data upsampling, where the data size was increased during training by applying different image processing operations such as random flips, image rotations, random croppings, and changes in brightness.

2.5 Evaluation Criteria for 3D Image Reconstruction

2.5.1 Metrics Based on Ground Truth Values

In cases where ground truth data are available as a binary virtual initial structure, e.g., for synthetic datasets, we calculated the following three absolute error metrics:

The first metric, the fraction of misplaced pixels (MP), measures the percentage of pixels whose predicted and ground truth values do not match. This metric was calculated using the following formula:

$$MP = \left(1 - \frac{TP + TN}{TP + FP + FN + TN}\right) \times 100$$
(1)

Fig. 6 Different multimodal ML architectures: **A** early fusion, **B** intermediate fusion, and **C** late fusion. Note: Each CNN model block (blue color) contains deep CNNs for semantic segmentation (see Appendix 1)



Parameter	Value
Patch size	64
Stride	0.5
Batch size	64
Epochs	100 with early stopping with patience=25
Loss	Dice loss
Optimizer	Adam
Learning rate	0.0001, adapted with a patience of 10 (reduction factor 10)

where TP denotes the number of true positives, TN denotes the number of true negatives, FP denotes the number of false positives, and FN denotes the number of false negatives. function (TPCF), which is the probability of having two points in the same material phase at a given distance from each other in x-, y-, and z-directions. Let this function calculated in the three spatial directions be denoted as f^x , f^y , and f^{z} . When these functions are uniformly discretized with *n* data points, we obtain the function values f_i^x , f_i^y , and f_i^z , where *i* ranges from 1 to *n*. TPCFs statistically characterize the microstructure in different spatial directions. For isotropic microstructures, identical TPCFs are expected in all spatial directions. Conversely, the differences between the TPCFs in different directions are a measure of the anisotropy of the microstructure. To quantify these differences, we calculated the L_2 differences between the TPCF in xand z-directions and y- and z-directions. These L_2 differences were averaged to obtain the final anisotropy metric as follows:

$$e_{L_2}^{\text{TPCF}} = \frac{1}{2} \left(\frac{2 \times \sqrt{\sum_{i=1}^n (f_i^x - f_i^z)^2}}{\sqrt{\sum_{i=1}^n (f_i^z)^2} + \sqrt{\sum_{i=1}^n (f_i^z)^2}} + \frac{2 \times \sqrt{\sum_{i=1}^n (f_i^y - f_i^z)^2}}{\sqrt{\sum_{i=1}^n (f_i^y)^2} + \sqrt{\sum_{i=1}^n (f_i^z)^2}} \right)$$
(4)

The second metric, the percentage of misplaced gold pixels (MGP), calculates falsely predicted gold pixels using ground truth values. One should be careful while using this metric alone, as FP is not considered in this metric. MGP is calculated as follows:

$$MGP = \left(1 - \frac{TP}{TP + FN}\right) \times 100$$
(2)

The third metric, the Dice score (DS), measures the overlapping regions between predicted and ground truth binarized images. It provides a valuable measure when data imbalances exist. DS takes values from 0 to 1, 1 being the best performance indicator. DS is calculated as follows:

$$DS = \frac{2 TP}{2 TP + FN + FP}.$$
(3)

We computed the DS for both the material and pore phases and then averaged them to obtain the mean Dice score (MDS).

2.5.2 Metrics Based on Anisotropy in the Absence of Ground Truth Values

When ground truth data are unavailable, e.g., for real HNPG FIB tomography, anisotropy-based metrics are used to assess ML model performance under the assumption of isotropy of the actual nanostructure [12]. These metrics account for the *shine-through effect* observed in the *z*-direction. Three metrics are calculated in the *x*-, *y*-, and *z*-directions and compared to evaluate anisotropy based on the three functions. The first metric is based on the two-point correlation

A similar anisotropy metric can be defined using the lineal path function (LPF) instead of the TPCF. The LPF measures the probability that two points at a certain distance in a certain direction can be connected by a line fully located in the same phase. The resulting anisotropy metric $e_{L_2}^{\text{LPF}}$ is calculated analogously to $e_{L_2}^{\text{TPCF}}$. The third metric, $e_{L_2}^{D}$ is a similar metric and calculates the average difference of ligament diameters in *x*- and *z*-directions and *y*- and *z*-directions:

$$e_{L_2}^D = \frac{1}{2} \left(\sqrt{\frac{(D_{xz} - D_{xy})^2}{D_{xy}^2}} + \sqrt{\frac{(D_{yz} - D_{xy})^2}{D_{xy}^2}} \right)$$
(5)

Here, D_{ij} denotes the calculated average diameter of ligaments in the *ij* plane with $i, j \in \{x, y, z\}$. When calculated for a completely isotropic structure, zero errors indicate the best reconstruction performance. However, higher error values for these functions suggest anisotropy in the reconstructed structure. For an underlying actual isotropic microstructure, this indicates a segmentation error.

3 Results and Discussion

3.1 Comparison of Different Multimodal ML Architectures

First, we performed a comparative analysis of the three multimodal ML architectures to identify the most effective segmentation model. We trained all three architectures, as described in Sect. 2.2, using synthetic datasets (s-1 kV, s-2 kV, and s-4 kV). After fine-tuning these models, we evaluated their performance using the metrics outlined in Sect. 2.5.1, leveraging the availability of ground truth data for the synthetic dataset. It is essential to emphasize that the synthetic dataset used for metrics calculation remained entirely isolated from that used during the training process. Our results, presented in Table 2, indicate that the late fusion architecture excelled among the three options.

Notably, the intermediate fusion architecture exhibited significantly poorer metrics than the late fusion architecture. This decline in performance can be attributed to the large size of the ML model, which posed challenges for

 Table 2
 Performance comparison of the different multimodal architectures on the synthetic dataset

MP↓	MGP↓	MDS ↑	
0	0	1	
2.8	20.33	0.93	
2.58	6.92	0.94	
0.23	0.94	0.99	
	MP↓ 0 2.8 2.58 0.23	MP↓ MGP↓ 0 0 2.8 20.33 2.58 6.92 0.23 0.94	

The first row in the table represents the target metric values for the original dataset (ground truth)

optimization given the limited training data. MP, MGP, and MDS were significantly less favorable for the more straightforward multimodal architecture, early fusion. In addition, we examined the behavior of the late fusion network on the *shine-through effect* by substituting the ensemble layer with a voting mechanism. This adaptation revealed weights of 0.5, 0.3, and 0.2 for CNN models trained individually on the s-1 kV, s-2 kV, and s-4 kV datasets, respectively, signifying that the model learns valuable insights from the 2- and 4-kV datasets despite their *shine-through effects*. On the basis of these comparative findings, we decided to proceed with the late fusion architecture for all subsequent parts of this study.

3.2 Comparison of Segmentation Methods (Synthetic Data)

Subsequently, we performed a comparative analysis, pitting our multimodal ML method (ML-multiV) against the cluster-based k-means clustering algorithm and ML models trained using individual single kV datasets, denoted as ML-singleV. The results are tabulated in Table 3, featuring metrics such as MP, MGP, and MDS for the reconstructed simulated structure. ML-singleV (s-1 kV), ML-singleV (s-2 kV), and ML-singleV (s-4 kV) represent cases where the

Table 3Quantitative evaluationof different segmentationmethods using syntheticdatasets

Method		k-means (k=3)			ML-singleV			ML-	
Measure	Original	s-1 kV	s-2 kV	s-4 kV	s-1 kV	s-2 kV	s-4 kV	multiV	
MP↓	0.000	4.455	9.490	18.626	0.245	0.654	1.407	0.225	
MGP↓	0.000	8.776	15.573	20.904	0.963	2.512	6.466	0.944	
MDS ↑	1.000	0.904	0.815	0.698	0.994	0.985	0.967	0.995	

The last column shows the results of our new multimodal ML method trained on a synthetic multiV dataset



Fig.7 A Slice of a synthetic microstructure (ground truth) and segmentation results of Monte Carlo-simulated BSE images using k-means clustering (top row) and the ML-singleV method (bottom

row) of **B** s-1 kV, **C** s-2 kV, **D** s-4 kV datasets, and **E** our multimodal ML-multiV method. Scale bar: 300 nm

ML model was trained and tested using only a single kV dataset, s-1 kV, s-2 kV, and s-4 kV, respectively.

Notably, our multimodal ML method, ML-multiV, outperformed all alternative techniques assessed. All ML models surpassed the cluster-based k-means clustering method when applied to their respective individual datasets. The best results were observed for the multimodal ML approach, particularly when considering all three datasets for segmentation. This underscores the distinct advantage gained from the *additional* information acquired through images captured at various accelerating voltages.

Supplementary (Appendix) Table 7 provides a detailed exploration of anisotropy-based metrics for each segmentation method, reaffirming the trends observed in Table 3. In addition, Fig. 7 offers a visual representation of the segmentation outputs, further supporting the efficacy of our multimodal ML technique.

3.3 Comparison of Performance for Real HNPG Data

We have demonstrated the superior performance of our multimodal ML approach on synthetic datasets created using Monte Carlo simulations of the FIB tomography process. To validate these results on real data, we assessed the segmentation performance of our ML-multiV method on real HNPG FIB tomography data (r-1 kV, r-2 kV, and r-4 kV) using anisotropy-based metrics (see Sect. 2.5.2). The outcomes presented in Table 4 confirm the advantages of our method, ML-multiV, over alternatives when applied to real FIB tomography data. Figure 8 shows a single slice from a segmented real HNPG dataset using different segmentation methods. This figure illustrates the enhanced ability of all ML-based techniques in mitigating the *shine-through effect* when compared with classical segmentation methods. Note that ML-multiV, on average, exhibits more than 50% improvement in performance based on anisotropy measures compared with k-means clustering. Furthermore, the enhancement over k-means clustering (r-1 kV) in anisotropy measures exceeds 30%.

4 Conclusion

FIB-SEM tomography data are affected by artifacts such as the *shine-through effect* and the resulting ambiguity in image intensities. These artifacts make it difficult to use cluster-based segmentation methods, such as k-means clustering. More advanced ML-based methods can efficiently suppress the *shine-through effect*, even when trained only on a single set of synthetic FIB tomography images. The reconstruction performance can be further improved using more than one set of FIB tomography data for the same system. Exploiting this idea, we developed an overdetermined system for FIB-SEM tomography of nanostructured materials such as HNPG. We accomplished this by combining FIB tomography data collected for the same system at different acceleration voltages. The additional data collected in this way can help decide with greater certainty whether certain high-intensity pixels of the SEM image belong to the surface area or are rather shine-through artifacts from deeper layers that should ideally be neglected.

Table 4Error measures basedon anisotropy of reconstructedmicrostructure achieved usingfour different microstructurereconstruction methods

Method	k-means (k=3)		ML-single	ML-singleV			
Measure	r-1 kV	r-2 kV	r-4 kV	r-1 kV	r-2 kV	r-4 kV	multiV	
$e_{L_2}^{\text{TPCF}}\downarrow$	0.1645	0.1899	0.2742	0.1454	0.1686	0.2708	0.1206	
$P_{L_2}^{LPF} \downarrow$	0.0531	0.2494	0.2369	0.0591	0.0911	0.1810	0.0489	
$e_{L_2}^{D}\downarrow$	0.0312	0.1943	0.1858	0.0304	0.0370	0.1383	0.0119	

The best possible error value is 0 for all measures

Fig. 8 Image segmentation results of an example region of a real HNPG dataset using **A** k-means clustering (r-1 kV), **B** ML-singleV (r-2 kV), and **C** our multimodal ML-multiV. Scale bar: 300 nm





Fig. 9 Schematic representation of U-Net architecture with residual connections

This study demonstrated that a multimodal ML method using imaging data collected with various acceleration voltages can outperform classical segmentation methods using only one dataset (obtained with a single acceleration voltage). We demonstrated this specifically using a multimodal ML architecture that combined imaging information obtained at acceleration voltages of 1, 2, and 4 kV.

Appendix 1: Machine Learning Architecture

We designed custom U-Net-based architectures for multimodal ML models (Fig. 6). These architectures were tailored for each fusion method and differed in their approach to processing image data. In all U-Net architectures [32, 33], we incorporated customizations such as residual connections, padding, and the number of encoding/decoding blocks (Fig. 9). After evaluating the performance of various architectures for different fusion techniques, we selected the following:

In the early fusion approach, we opted for a 3D U-Net model comprising four encoding blocks with residual connections.

In the case of intermediate fusion, we narrowed our focus to a 2D CNN and a 2D CNN with adjacent slices because of the significant size of the multimodal ML model. To our surprise, the 2D CNN proved to be the most effective, probably because of the constraints of the limited dataset size and the overall large model size after intermediate fusion. Consequently, we adopted a 2D U-Net model that features two encoding blocks with residual connections. The fully connected layer block incorporated two convolutional layers: The first expanded output channels to 64, followed by a second output classifier layer with a kernel size of 1. For the late fusion approach, we trained and compared the 2D CNN, 2D CNN with adjacent slices, and 3D CNN architectures, with the 2D CNN featuring adjacent slices outperforming the others. This approach employed seven adjacent slices, four encoding blocks, and residual connections and included an ensemble block with a convolutional layer and a kernel size of 1.

Appendix 2: Training Curves

Figure 10 depicts training and validation Dice loss curves. These curves display the mean Dice loss over epochs, with the blue line representing training scores and the orange line representing validation scores. We used data augmentation during training, which made the training dataset more complex. Consequently, validation Dice loss values were consistently lower than training Dice loss values in all curves.

Appendix 3: Effect of 3D Reconstruction on Material Properties (Solid Fraction)

The solid fraction (ϕ), which is a critical property in materials science, quantifies the volume of the solid phase within a structure. It significantly influences mechanical and optical properties, underscoring the importance of its accurate measurement, which relies on precise 3D reconstruction. The solid fraction can be calculated from the binary structure as follows:

$$\phi = \frac{N_m}{N_{\text{total}}} \tag{6}$$

Fig. 10 Training and validation data Dice loss function for ML method singleV trained on **A** s-1 kV, **B** s-2 kV, **C** s-4 kV, and **D** our multimodal ML-multiV method



Table 5Quantitative evaluationof different segmentationmethods on material properties(solid fraction) of syntheticdatasets

Table 6Quantitative evaluationof different segmentationmethods on material properties(solid fraction) in real datasets

Method		k-means (k-means (k=3)				ML-singleV			
Measure	Original	s-1 kV	s-2 kV	s-4 kV	s-1 l	xV s-2	kV s-4 k	V multiV		
Solid Fraction	0.123	0.147	0.180	0.258	0.12	3 0.1	23 0.121	0.123		
Method	k-means	(k=3)		Ν	1L-single	eV		ML-		
Measure	r-1 kV	r-2 kV	r-4 kV	V r-	1 kV	r-2 kV	r-4 kV	multiV		
Solid Fraction	0.214	0.253	0.355	0	.164	0.123	0.247	0.130		

 Table 7
 Performance

 comparison of different
 segmentation methods based on

 anisotropy for synthetic datasets
 setting

Method		k-means (k=3)			ML-singl	ML-		
Measure	Original	s-1 kV	s-2 kV	s-4 kV	s-1 kV	s-2 kV	s-4 kV	multiV
$e_{I_{2}}^{\text{TPCF}}\downarrow$	0.0965	0.1609	0.2313	0.2317	0.0963	0.0976	0.0936	0.0961
$e_{I_2}^{LPF}\downarrow$	0.0087	0.0734	0.1442	0.2336	0.0100	0.0102	0.0143	0.0100
$e_{L_2}^{D}\downarrow$	0.0120	0.0583	0.1087	0.1805	0.0111	0.0091	0.0078	0.0106

where N_m represents voxels within phase *m* and N_{total} denotes the total voxel count. Synthetic data with ground truth allow us to observe the impact of reconstruction on the solid fraction. Table 5 shows that the ML-based methods yield similar solid fractions, while with k-means clustering, the solid fraction increases with increasing voltage, indicating its struggle with the *shine-through effect*.

Real FIB-SEM image data (r-1 kV, r-2 kV, and r-4 kV) lack ground truth, limiting direct comparison. Nevertheless, Table 6 shows that ML-singleV (r-1 kV), ML-singleV (r-2 kV), and ML-multiV exhibit solid fractions indicative of *realistic* hierarchical nanoporous materials.

Appendix 4: Additional Results Using Anisotropy-Based Error Measures for Synthetic Data

In this section, we computed anisotropy-based errors as detailed in Sect. 2.5.2 to compare the performance of different segmentation methods. Table 7 presents the comprehensive metrics for the synthetic datasets including for the original dataset, serving as reference values for evaluating the outcomes obtained from different methods.

Author Contributions All authors read and approved the final manuscript. Sardhara, Aydin, Cyron, and Ritter contributed to the conception and design of the study. Shkurmanov acquired FIB-SEM images of HNPG and calculated slice thicknesses. Li generated the LWM database. Shi and Riedel prepared the HNPG sample. Sardhara wrote the first draft of the manuscript. All authors contributed to the manuscript.

Funding This work was funded by the Deutsche Forschungsgemeinschaft (DFG, German Research Foundation) - SFB 986 - Project number 192346071.

Availability of Data and Material The datasets generated and analyzed for this study can be found in TUHH Open Research repository. DOI: https://doi.org/10.15480/882.8927

Declarations

Conflict of interest The authors declare that the research was conducted in the absence of any commercial or financial relationships that could be construed as a potential conflict of interest.

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